

LM2423TE

220V Monolithic Triple Channel 15 MHz CRT DTV Driver

General Description

The LM2423 is a triple channel high voltage CRT driver circuit designed for use in DTV applications. The IC contains three high input impedance, wide band amplifiers which directly drive the RGB cathodes of a CRT. Each channel has its gain internally set to -54 and can drive CRT capacitive loads as well as resistive loads present in other applications, limited only by the package's power dissipation.

The IC is packaged in an industry standard 11-lead TO-220 molded plastic power package designed specifically to meet high voltage spacing requirements. See Thermal Considerations section.

Features

- 15 MHz bandwidth at 130V_{P-P} output swing
- Current output for IK feedback systems
- Greater than 130V_{P-P} output swing capability
- 0V to 5V input voltage range
- Stable with 0 pF-20 pF capacitive loads and inductive peaking networks
- Convenient TO-220 staggered thin lead package style

Applications

 DC coupled DTV applications using the 480p format as well as standard NTSC and PAL formats.

Connection Diagram

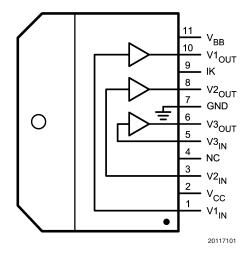


FIGURE 1. Top View Order Number LM2423TE See NS Package Number TE11B NOPB Available only with lead free plating

Schematic Diagram

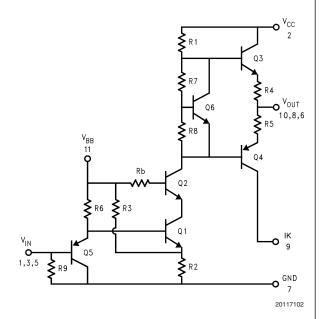


FIGURE 2. Simplified Schematic Diagram (One Channel)

Absolute Maximum Ratings (Notes 1,

3)

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/Distributors for availability and specifications.

Lead Temperature

(Soldering, <10 sec.) 300°C

ESD Tolerance,

 $\begin{array}{ccc} \text{Human Body Model} & 2 \text{ kV} \\ \text{Machine Model} & 200\text{V} \\ \text{Junction Temperature} & 150 ^{\circ}\text{C} \\ \theta_{\text{JC}} \left(\text{typ} \right) & 2.2 ^{\circ}\text{C/W} \end{array}$

Operating Ratings (Note 2)

 V_{CC} +100V to +230V V_{BB} +7V to +13V V_{IN} +0V to +5V V_{OUT} +40V to +215V Case Temperature 110°C

Do not operate the part without a heat sink.

Electrical Characteristics

(See Figure 3 for Test Circuit). Unless otherwise noted: V_{CC} = +220V, V_{BB} = +12V, C_L = 10 pF, T_C = 50°C. DC Tests: V_{IN} = +2.75 V_{DC} . AC Tests: Output = 130 V_{PP} (60V - 190V) at 1 MHz.

Symbol	Parameter	Conditions	LM2423			Units
			Min	Тур	Max	Units
I _{cc}	Supply Current	No Input Signal, No Video Input, No Output Load	14	21	28	mA
I _{BB}	Bias Current		9	15	22	mA
V _{OUT, 1}	DC Output Voltage	No AC Input Signal, V _{IN} = 2.75V _{DC}	120	125	130	V _{DC}
V _{OUT, 2}	DC Output Voltage	No AC Input Signal, $V_{IN} = 1.25V_{DC}$	200	205	210	V _{DC}
A _V	DC Voltage Gain	No AC Input Signal	-51	-54	-57	V/V
ΔA_V	Gain Matching	(Note 4), No AC Input Signal		1.0		dB
LE	Linearity Error	(Notes 4, 5), No AC Input Signal		8		%
t _r	Rise Time, 60V to 190V	(Note 6), 10% to 90%		22		ns
+OS	Overshoot			8		%
t _f	Fall Time, 60V to 190V	(Note 6), 90% to 10%		21		ns
-OS	Overshoot	(Note 6)		4		%
Ik _{ERROR} ,	Current Output Error, No Load	Output Current = 50 μA	-52	0	52	μА
Δlk _{ERROR}	Current Output Difference Between Channels	Output Current = 50 μA to 200 μA	0	NA	32	μΑ

Note 1: Absolute Maximum Ratings indicate limits beyond which damage to the device may occur.

Note 2: Operating ratings indicate conditions for which the device is functional, but do not guarantee specific performance limits. For guaranteed specifications and test conditions, see the Electrical Characteristics. Datasheet min/max specification limits are guaranteed by design, test, or statistical analysis. The guaranteed specifications apply only for the test conditions listed. Some performance characteristics may change when the device is not operated under the listed test conditions.

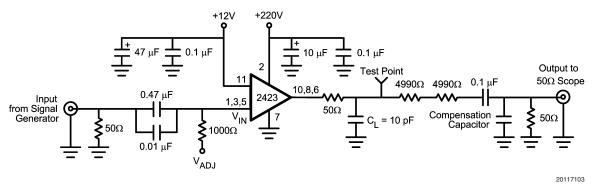
Note 3: All voltages are measured with respect to GND, unless otherwise specified.

Note 4: Calculated value from Voltage Gain test on each channel.

Note 5: Linearity Error is the variation in DC gain from V_{IN} = 1.15V to V_{IN} = 4.35V.

Note 6: Input from signal generator: t_r , $t_f < 1$ ns.

AC Test Circuit



Note: 10 pF load includes parasitic capacitance.

FIGURE 3. Test Circuit (One Channel)

Figure 3 shows a typical test circuit for evaluation of the LM2423. This circuit is designed to allow testing of the LM2423 in a 50Ω environment without the use of an expensive FET probe. The two 4990Ω resistors form a 400:1 divider with the 50Ω resistor and the oscilloscope. A test point is included for easy use of an oscilloscope probe. The compensation capacitor is used to compensate the network to achieve flat frequency response.

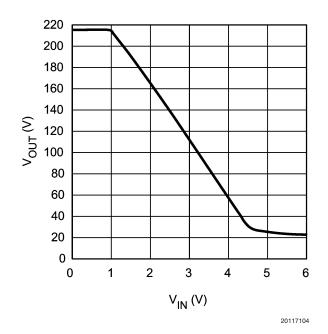


FIGURE 4. $V_{\rm OUT}$ vs $V_{\rm IN}$

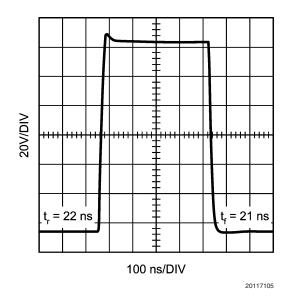


FIGURE 5. LM2423 Pulse Response

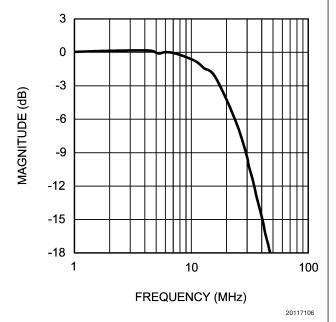


FIGURE 6. Bandwidth

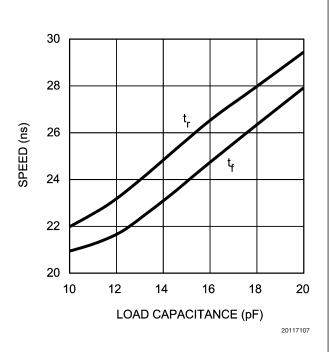


FIGURE 7. Speed vs Load Capacitance

Typical Performance

Characteristics (V_{CC} = +220 V_{DC} , V_{BB} = +12 V_{DC} , C_L = 10 pF, V_{OUT} = 130 V_{PP} (60 V_C - 190 V_C), T_C = 50°C, Test Circuit—*Figure 3* unless otherwise specified) (Continued)

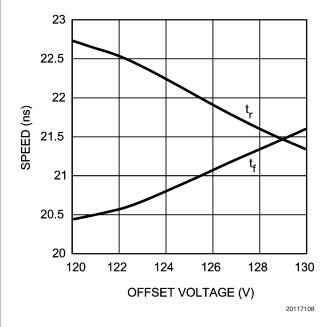


FIGURE 8. Speed vs Offset

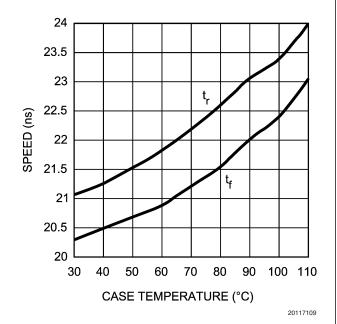


FIGURE 9. Speed vs Case Temperature

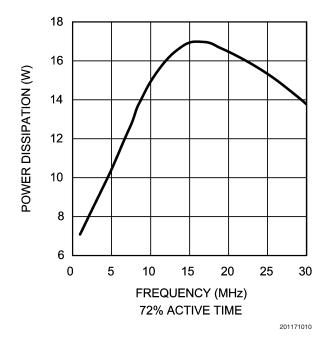


FIGURE 10. Power Dissipation vs Frequency

FIGURE 11. Safe Operating Area

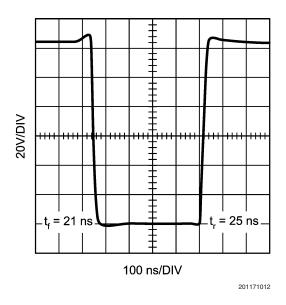


FIGURE 12. LM2423 Cathode Response

Theory of Operation

The LM2423 is a high voltage monolithic three channel CRT driver suitable for DTV applications. The LM2423 operates with 220V and 12V power supplies. The part is housed in the industry standard 11-lead TO-220 molded plastic power package with thin leads for improved metal-to-metal spacing. The circuit diagram of the LM2423 is shown in *Figure 2*. The PNP emitter follower, Q5, provides input buffering. Q1 and Q2 form a fixed gain cascode amplifier with resistors R1 and R2 setting the gain at -54. Emitter followers Q3 and Q4 isolate the high output impedance of the cascode stage from the capacitance of the CRT cathode, which decreases the sensitivity of the device to load capacitance. Q6 provides biasing to the output emitter follower stage to reduce crossover distortion at low signal levels.

Figure 3 shows a typical test circuit for evaluation of the LM2423. This circuit is designed to allow testing of the LM2423 in a 50 Ω environment without the use of an expensive FET probe. In this test circuit, the two 4.99 k Ω resistors form a 400:1 wideband, low capacitance probe when connected to a 50 Ω coaxial cable and a 50 Ω load (such as a 50 Ω oscilloscope input). The input signal from the generator is ac coupled to the base of Q5.

Application Hints

INTRODUCTION

National Semiconductor (NSC) is committed to provide application information that assists our customers in obtaining the best performance possible from our products. The following information is provided in order to support this commitment. The reader should be aware that the optimization of performance was done using a specific printed circuit board designed at NSC. Variations in performance can be realized due to physical changes in the printed circuit board and the application. Therefore, the designer should know that component value changes may be required in order to optimize performance in a given application. The values shown in this document can be used as a starting point for evaluation purposes. When working with high bandwidth circuits, good layout practices are also critical to achieving maximum performance.

IMPORTANT INFORMATION

The LM2423 performance is targeted for the HDTV market. The application circuits shown in this document to optimize performance and to protect against damage from CRT arc over are designed specifically for the LM2423. If another member of the LM242X family is used, please refer to its datasheet.

POWER SUPPLY BYPASS

Since the LM2423 is a wide bandwidth amplifier, proper power supply bypassing is critical for optimum performance. Improper power supply bypassing can result in large overshoot, ringing or oscillation. 0.1 μF capacitors should be connected from the supply pins, $V_{\rm CC}$ and $V_{\rm BB}$, to ground, as close to the LM2423 as is practical. Additionally, a 22 μF or larger electrolytic capacitor should be connected from both supply pins to ground reasonably close to the LM2423.

ARC PROTECTION

During normal CRT operation, internal arcing may occasionally occur. This fast, high voltage, high-energy pulse can damage the LM2423 output stage. The application circuit

shown in Figure 13 is designed to help clamp the voltage at the output of the LM2423 to a safe level. The clamp diodes, D1 and D2, should have a fast transient response, high peak current rating, low series impedance and low shunt capacitance. 1SS83 or equivalent diodes are recommended. D1 and D2 should have short, low impedance connections to V_{CC} and ground respectively. The cathode of D1 should be located very close to a separately decoupled bypass capacitor (C3 in Figure 13). The ground connection of D2 and the decoupling capacitor should be very close to the LM2423 ground. This will significantly reduce the high frequency voltage transients that the LM2423 would be subjected to during an arc over condition. Resistor R2 limits the arc over current that is seen by the diodes while R1 limits the current into the LM2423 as well as the voltage stress at the outputs of the device. R2 should be a ½W solid carbon type resistor. R1 can be a 1/4W metal or carbon film type resistor. Having large value resistors for R1 and R2 would be desirable, but this has the effect of increasing rise and fall times. Inductor L1 is critical to reduce the initial high frequency voltage levels that the LM2423 would be subjected to. The inductor will not only help protect the device but it will also help minimize rise and fall times as well as minimize EMI. For proper arc protection, it is important to not omit any of the arc protection components shown in Figure 13.

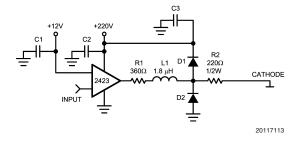


FIGURE 13. One Channel of the LM2423 with the Recommended Application Circuit

EFFECT OF LOAD CAPACITANCE

Figure 7 shows the effect of increased load capacitance on the speed of the device. This demonstrates the importance of knowing the load capacitance in the application. Increasing the load capacitance from 10 pF to 20 pF adds about 7 ns to both the rise and fall times. It is important to keep the board capacitance as low as possible to maximize the speed of the driver.

EFFECT OF OFFSET

Figure 8 shows the variation in rise and fall times when the output offset of the device is varied from 120V to $130V_{DC}$. The rise and fall times both show a variation of about 6% relative to the center data point $(125V_{DC})$. The rise time increases in speed with the increase in offset voltage and the fall time decreased in speed with the increase in offset voltage.

THERMAL CONSIDERATIONS

Figure 9 shows the performance of the LM2423 in the test circuit shown in Figure 3 as a function of case temperature. The figure shows that both the rise and fall times of the LM2423 increase by approximately 14% as the case temperature increases from 30°C to 110°C. This corresponds to a speed degradation of 1.4% for every 10°C rise in case temperature.

Figure 10 shows the maximum power dissipation of the LM2423 vs. Frequency when all three channels of the device are driving into a 10 pF load with a $130V_{P-P}$ alternating one pixel on, one pixel off. The graph assumes a 72% active time (device operating at the specified frequency), which is typical in a TV application. The other 28% of the time the device is assumed to be sitting at the black level (190V in this case). This graph gives the designer the information needed to determine the heat sink requirement for his application. The designer should note that if the load capacitance is increased the AC component of the total power dissipation would also increase.

The LM2423 case temperature must be maintained below 110°C. If the maximum expected ambient temperature is 60°C and the maximum power dissipation is 17W (from *Figure 10*, 15 MHz) then a maximum heat sink thermal resistance can be calculated:

$$R_{TH} = \frac{110^{\circ}C - 60^{\circ}C}{16.9} = 3.0^{\circ}C/W$$

This example assumes a capacitive load of 10 pF and no resistive load. The designer should note that if the load capacitance is increased the AC component of the total power dissipation will also increase.

OPTIMIZING TRANSIENT RESPONSE

Referring to Figure 13, there are three components (R1, R2 and L1) that can be adjusted to optimize the transient response of the application circuit. Increasing the values of R1 and R2 will slow the circuit down while decreasing overshoot. Increasing the value of L1 will speed up the circuit as well as increase overshoot. It is very important to use inductors with very high self-resonant frequencies, preferably above 300 MHz. Ferrite core inductors from J.W. Miller Magnetics (part # 78FR--K) were used for optimizing the performance of the device in the NSC application board. The values shown in Figure 13 can be used as a good starting point for the evaluation of the LM2423. Using a variable resistor for R1 will simplify finding the value needed for optimum performance in a given application. Once the optimum value is determined the variable resistor can be replaced with a fixed value. Due to arc over considerations it is recommended that the values shown in Figure 13 not be changed by a large amount.

Figure 12 shows the typical cathode pulse response with an output swing of 130V_{PP} inside a modified Sony TV using a Sony pre-amp.

PC BOARD LAYOUT CONSIDERATIONS

For optimum performance, an adequate ground plane, isolation between channels, good supply bypassing and minimizing unwanted feedback are necessary. Also, the length of the signal traces from the signal inputs to the LM2423 and from the LM2423 to the CRT cathode should be as short as possible. The following references are recommended:

Ott, Henry W., "Noise Reduction Techniques in Electronic Systems", John Wiley & Sons, New York, 1976.

"Video Amplifier Design for Computer Monitors", National Semiconductor Application Note 1013.

Pease, Robert A., "Troubleshooting Analog Circuits", Butterworth-Heinemann, 1991.

Because of its high small signal bandwidth, the part may oscillate in a TV if feedback occurs around the video channel through the chassis wiring. To prevent this, leads to the video amplifier input circuit should be shielded, and input circuit wiring should be spaced as far as possible from output circuit wiring.

TYPICAL APPLICATION

A typical application of the LM2423 is shown in the schematic for the NSC demonstration board in Figure 14. Used in conjunction with a pre-amp with 1.2V black level output no buffer transistors are required to obtain the correct black level at the cathodes. If the pre-amp has a black level closer to 2V, then an NPN transistor should be used as shown in Figure 14 to drop the video black level voltage closer to 1.2V. It is important that the TV designer use component values for the driver output stage close to the values shown in Figure 14. These values have been selected to protect the LM2423 from arc over. Diodes D1-D6 must also be used for proper arc over protection. The NSC demonstration board can be used to evaluate the LM2423 in a TV. If the NSC demonstration board is used for evaluating the LM2423, then U2, the voltage regulator, would not be used and +12V would be connected directly to V_{BB} by inserting JP1.

NSC DEMONSTRATION BOARD

Figure 15 shows the routing and component placement on the NSC LM2423 demonstration board. This board provides a good example of a layout that can be used as a guide for future layouts. Note the location of the following components:

- C5—V_{CC} bypass capacitor, located very close to pin 2 and ground pins
- C6—V_{BB} bypass capacitor, located close to pin 11 and ground
- C7, C8—V_{CC} bypass capacitors, near LM2423 and V_{CC} clamp diodes. Very important for arc protection.

The routing of the LM2423 outputs to the CRT is very critical to achieving optimum performance. Figure 16 shows the routing and component placement from pin 10 (VOUT1) of the LM2423 to the blue cathode. Note that the components are placed so that they almost line up from the output pin of the LM2423 to the blue cathode pin of the CRT connector. This is done to minimize the length of the video path between these two components. Note also that D1, D3 and R15 are placed to minimize the size of the video nodes that they are attached to. This minimizes parasitic capacitance in the video path and also enhances the effectiveness of the protection diodes. The anode of protection diode D1 is connected directly to a section of the ground plane that has a short and direct path to the LM2423 ground pins. The cathode of D3 is connected to $V_{\rm CC}$ very close to decoupling capacitor C7 which is connected to the same area of the ground trace as D1. The diode placement and routing is very important for minimizing the voltage stress on the LM2423 during an arc over event.

This demonstration board uses large PCB holes to accommodate socket pins, which function to allow for multiple insertions of the LM2423 in a convenient manner. To benefit from the enhanced LM2423 package with thin leads, the device should be secured in small PCB holes to optimize the metal-to-metal spacing between the leads.

CURRENT OUTPUT FOR IK FEEDBACK SYSTEMS

The LM2423 can be used in DTV applications that use an IK feedback system. *Figure 14* shows an example of an interface circuit used to feed back the IK output of LM2423 to a preamplifier with an ac coupled IK input.

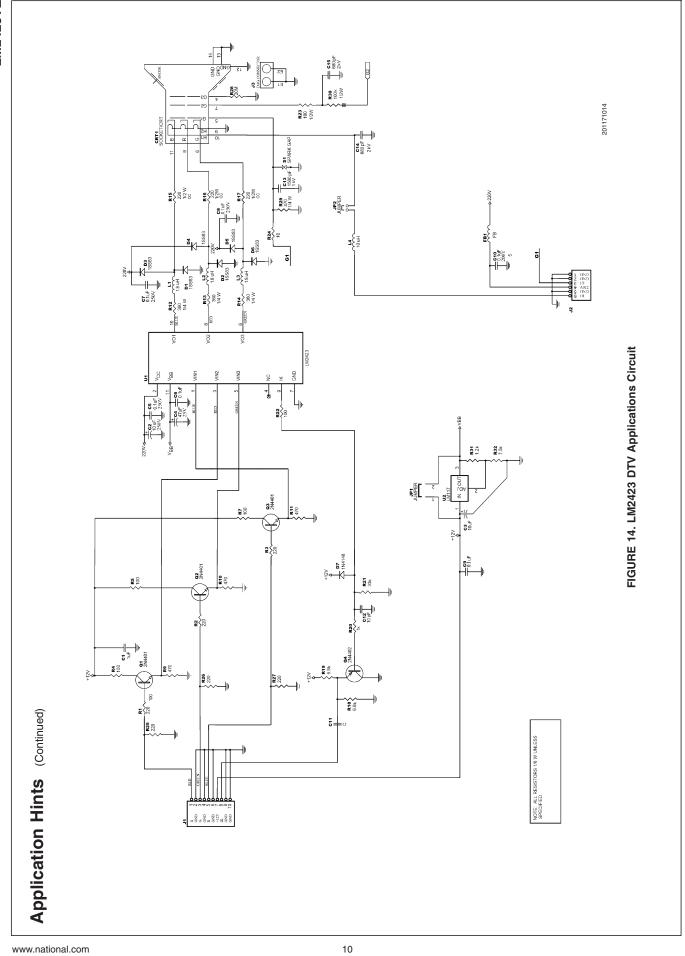
This feedback system consists of the preamp, LM2423, and interface circuit, forming a closed loop to automatically adjust the black level of the drive signals to the cutoff point of the RGB cathodes. Following is a description of the interface circuit operation.

The output at pin 9 of the LM2423 is filtered of high frequency noise by C12. D7 is used to limit the peak voltage at pin 9. Without this clamp this voltage would easily exceed 12V during active video, in which the cathode currents are much greater than the small currents being detected during vertical blanking. Exceeding 12V could damage Q4 and result in improper operation of the driver.

R21 is essential to convert the IK current to voltage. Choosing the value of R21 sets the gain of the feedback voltage, and consequently, the operating point of the tube. Once a

stable operating point is established, this point can be finetuned using the adjustment range of the feedback system or standard preamp controls. Changing the value of R21 will change the cutoff voltage at the cathode. A smaller value of R21 requires more IK current to maintain the feedback loop. The cutoff voltage set at the cathode will be lower to adjust to the higher IK current. This additional current must come from the cathode; therefore, the cathode voltage is lower to meet higher current requirement. A higher value of R21 will do the opposite, raising the cathode voltage because less IK current is needed to maintain the same voltage at R21.

The emitter follower, Q4, isolates R21 from the input impedance of the preamp. R18 and R19 bias the emitter of Q4 to limit the maximum voltage to the preamp. These resistor values should be chosen to limit the maximum voltage at the emitter and protect the preamp from any large voltages that would otherwise occur during active video. R2 and C8 are used for further filtering of the IK signal. C11 is used to AC couple the IK signal to the preamp. The advantage of AC coupling is that any DC component (leakage current from the driver) of the IK signal is not detected by the IK sense input of the preamp.



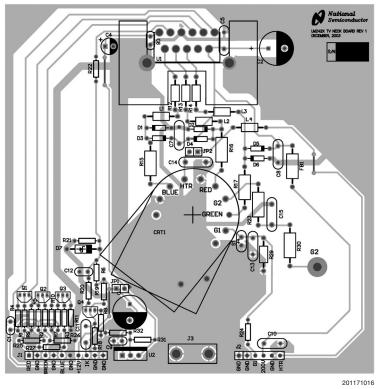


FIGURE 15. LM2423 DTV Demonstration Board Layout

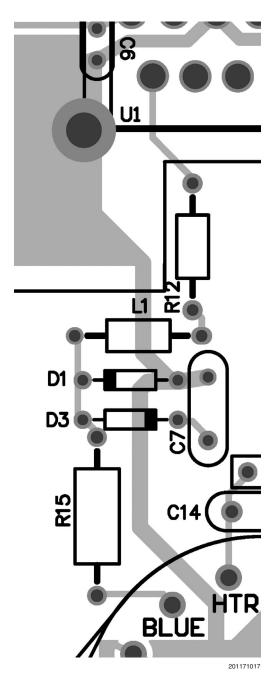
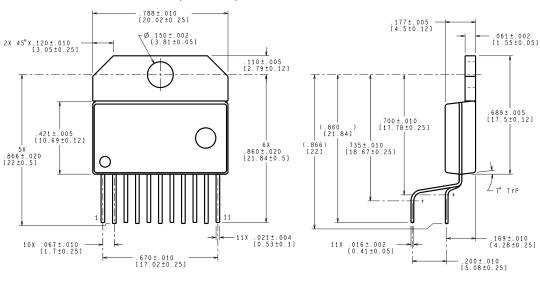


FIGURE 16. Trace Routing and Component Placement for Blue Channel Output

Physical Dimensions inches (millimeters) unless otherwise noted



CONTROLLING DIMENSION IS INCH VALUES IN [] ARE MILLIMETERS

TE11B (Rev A)

NOTE: Available only with lead free plating

NS Package Number TE11B Order Number LM2423TE NOPB

THE CONTENTS OF THIS DOCUMENT ARE PROVIDED IN CONNECTION WITH NATIONAL SEMICONDUCTOR CORPORATION ("NATIONAL") PRODUCTS. NATIONAL MAKES NO REPRESENTATIONS OR WARRANTIES WITH RESPECT TO THE ACCURACY OR COMPLETENESS OF THE CONTENTS OF THIS PUBLICATION AND RESERVES THE RIGHT TO MAKE CHANGES TO SPECIFICATIONS AND PRODUCT DESCRIPTIONS AT ANY TIME WITHOUT NOTICE. NO LICENSE, WHETHER EXPRESS, IMPLIED, ARISING BY ESTOPPEL OR OTHERWISE, TO ANY INTELLECTUAL PROPERTY RIGHTS IS GRANTED BY THIS DOCUMENT.

TESTING AND OTHER QUALITY CONTROLS ARE USED TO THE EXTENT NATIONAL DEEMS NECESSARY TO SUPPORT NATIONAL'S PRODUCT WARRANTY. EXCEPT WHERE MANDATED BY GOVERNMENT REQUIREMENTS, TESTING OF ALL PARAMETERS OF EACH PRODUCT IS NOT NECESSARILY PERFORMED. NATIONAL ASSUMES NO LIABILITY FOR APPLICATIONS ASSISTANCE OR BUYER PRODUCT DESIGN. BUYERS ARE RESPONSIBLE FOR THEIR PRODUCTS AND APPLICATIONS USING NATIONAL COMPONENTS. PRIOR TO USING OR DISTRIBUTING ANY PRODUCTS THAT INCLUDE NATIONAL COMPONENTS, BUYERS SHOULD PROVIDE ADEQUATE DESIGN, TESTING AND OPERATING SAFEGUARDS.

EXCEPT AS PROVIDED IN NATIONAL'S TERMS AND CONDITIONS OF SALE FOR SUCH PRODUCTS, NATIONAL ASSUMES NO LIABILITY WHATSOEVER, AND NATIONAL DISCLAIMS ANY EXPRESS OR IMPLIED WARRANTY RELATING TO THE SALE AND/OR USE OF NATIONAL PRODUCTS INCLUDING LIABILITY OR WARRANTIES RELATING TO FITNESS FOR A PARTICULAR PURPOSE, MERCHANTABILITY, OR INFRINGEMENT OF ANY PATENT, COPYRIGHT OR OTHER INTELLECTUAL PROPERTY RIGHT.

LIFE SUPPORT POLICY

NATIONAL'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS PRIOR WRITTEN APPROVAL OF THE CHIEF EXECUTIVE OFFICER AND GENERAL COUNSEL OF NATIONAL SEMICONDUCTOR CORPORATION. As used herein:

Life support devices or systems are devices which (a) are intended for surgical implant into the body, or (b) support or sustain life and whose failure to perform when properly used in accordance with instructions for use provided in the labeling can be reasonably expected to result in a significant injury to the user. A critical component is any component in a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system or to affect its safety or effectiveness.

National Semiconductor and the National Semiconductor logo are trademarks or registered trademarks of National Semiconductor Corporation. All other brand or product names may be trademarks or registered trademarks of their respective holders.

Copyright © 2006 National Semiconductor Corporation.

For the most current product information visit us at www.national.com.



National Semiconductor Americas Customer Support Center

Email: new.feedback@nsc.com Tel: 1-800-272-9959

www.national.com

National Semiconductor
Europe Customer Support Center

Fax: +49 (0) 180-530 85 86
Email: europe.support@nsc.com
Deutsch Tel: +49 (0) 69 9508 6208
English Tel: +44 (0) 870 24 0 2171

English Tel: +44 (0) 870 24 0 217 Français Tel: +33 (0) 1 41 91 8790 National Semiconductor Asia Pacific Customer Support Center Email: ap.support@nsc.com National Semiconductor Japan Customer Support Center Fax: 81-3-5639-7507 Email: jpn.feedback@nsc.com Tel: 81-3-5639-7560